ERRATUM

HIGH-ORDERED AND ULTRA-SENSITIVE PARTICLE-IN-BOWL METALLIC ARRAYS FOR SURFACE ENHANCED RAMAN SPECTROSCOPY

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The correct Fig. 2 should be as follows:

Fig. 2. SEM images of the nanostructure arrays after each fabrication process (a) SEM images of the etched PS beads that covered with Cr layer, (b) SEM images of the heterogeneous shadow mask, the outer circle is the Cr hole and the inner ring is the colloid residues, (c) SEM images of the Si template after substrate etching, (d) SEM images of the PIB arrays after lift-off process, the supporting is a conductive carbon disk and the PIB particle is totally gold. Insets are high-magnified SEM images.